



# AO4886

## 100V Dual N-Channel MOSFET

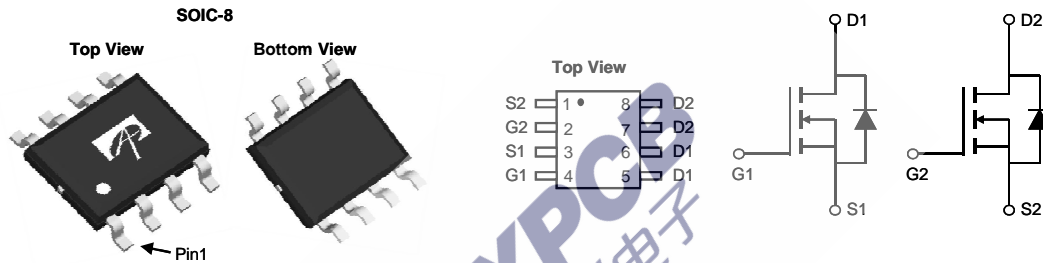
### General Description

The AO4886 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

### Product Summary

|                                    |                |
|------------------------------------|----------------|
| $V_{DS}$                           | 100V           |
| $I_D$ (at $V_{GS}=10V$ )           | 3.3A           |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )    | < 80m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = 4.5V$ ) | < 91m $\Omega$ |

100% UIS Tested  
100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                               | Symbol           | Maximum          | Units      |
|---|------------------|------------------|------------|
| Drain-Source Voltage                    | $V_{DS}$         | 100              | V          |
| Gate-Source Voltage                     | $V_{GS}$         | $\pm 20$         | V          |
| Continuous Drain Current                | $I_D$            | $T_A=25^\circ C$ | 3.3        |
|   |                  | $T_A=70^\circ C$ | 2.7        |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$         | 17               | A          |
| Avalanche Current <sup>C</sup>          | $I_{AS}, I_{AR}$ | 14               | A          |
| Avalanche energy $L=0.1mH$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 10               | mJ         |
| Power Dissipation <sup>B</sup>          | $P_D$            | $T_A=25^\circ C$ | 2.00       |
|   |                  | $T_A=70^\circ C$ | 1.28       |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$   | -55 to 150       | $^\circ C$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ          | Max  | Units        |
|--|-----------------|--------------|------|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 48           | 62.5 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | Steady-State | 74   | 90           |
| Maximum Junction-to-Lead                   | $R_{\theta JL}$ | 32           | 40   | $^\circ C/W$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ         | Max       | Units |
|-----------------------------|---------------------------------------|--|-----|-------------|-----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |             |           |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 100 |             |           | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =100V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |             | 1<br>5    | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V  |     |             | ±100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                   | 1.6 | 2.2         | 2.7       | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V  | 17  |             |           | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =3A<br>T <sub>J</sub> =125°C                          |     | 63.5<br>122 | 80<br>152 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =3A  |     | 70          | 91        |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =3A  |     | 20          |           | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |     | 0.74        | 1         | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |  |     |             | 2.5       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |             |           |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz  | 620 | 778         | 942       | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |  | 38  | 55          | 81        | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance          |  | 13  | 24          | 35        | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   | 0.7 | 1.45        | 2.2       | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |             |           |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =3A                             | 13  | 16.3        | 20        | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |  | 6.4 | 8.1         | 10        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |  | 2.2 | 2.8         | 3.4       | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |  | 2.4 | 4.1         | 5.8       | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, R <sub>L</sub> =16.7Ω,<br>R <sub>GEN</sub> =3Ω |     | 6           |           | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |  |     | 2.5         |           | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |  |     | 21          |           | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |  |     | 2.4         |           | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =3A, di/dt=500A/μs  | 14  | 21          | 28        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =3A, di/dt=500A/μs  | 65  | 94          | 123       | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

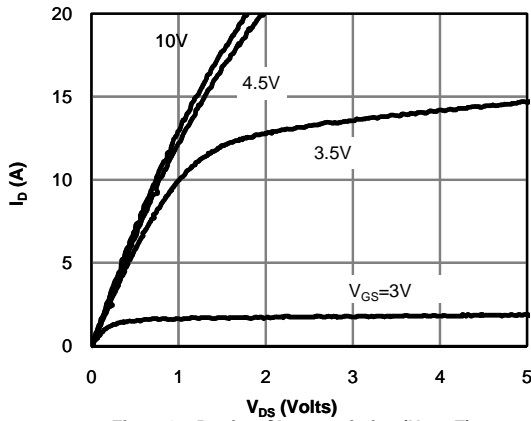


Figure 1: On-Region Characteristics (Note E)

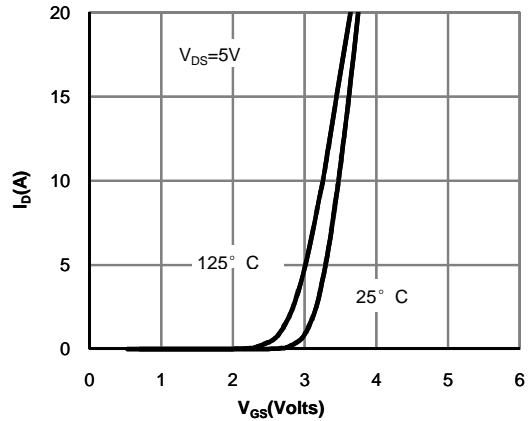


Figure 2: Transfer Characteristics (Note E)

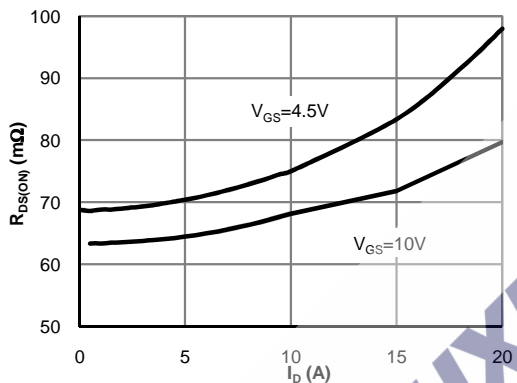


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

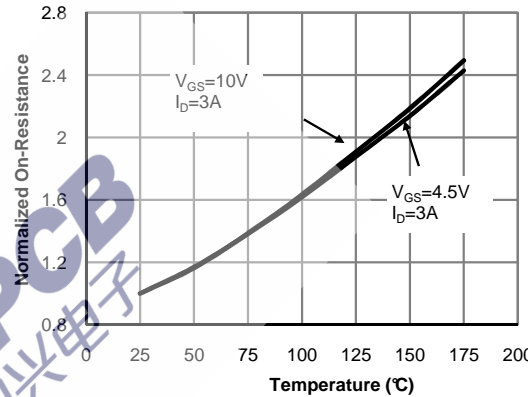


Figure 4: On-Resistance vs. Junction Temperature (Note E)

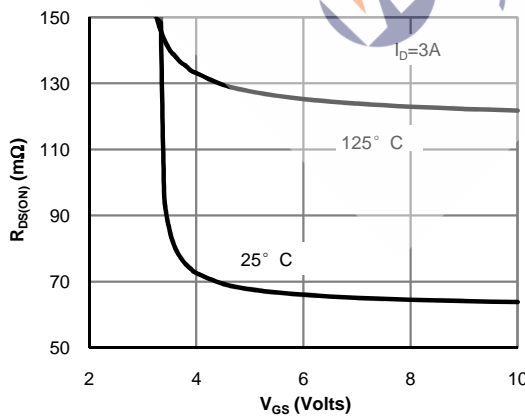


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

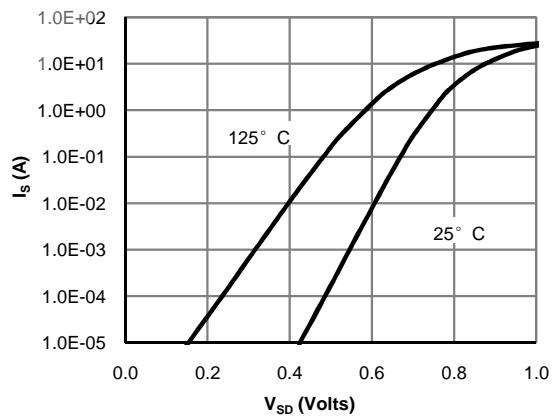
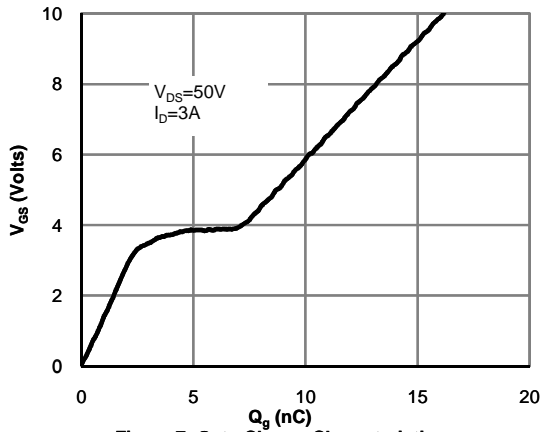
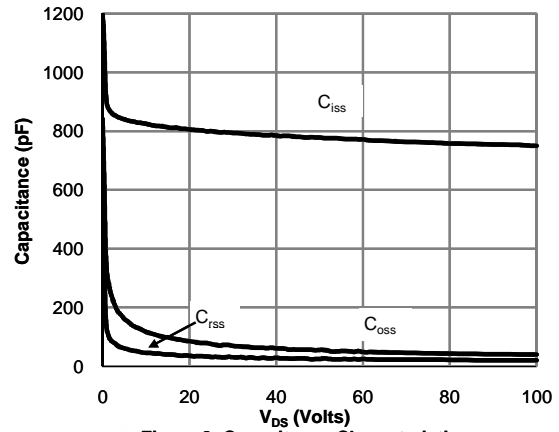


Figure 6: Body-Diode Characteristics (Note E)

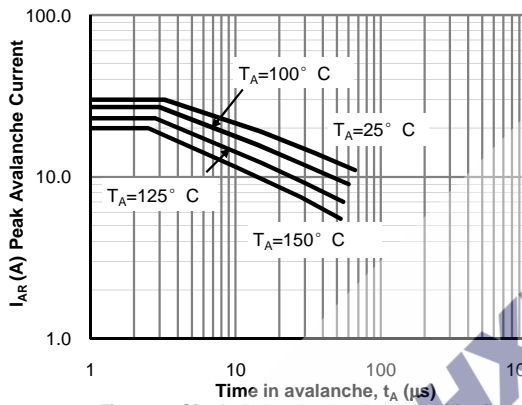
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



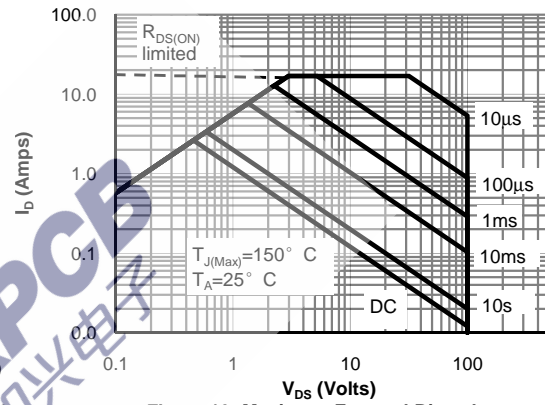
**Figure 7: Gate-Charge Characteristics**



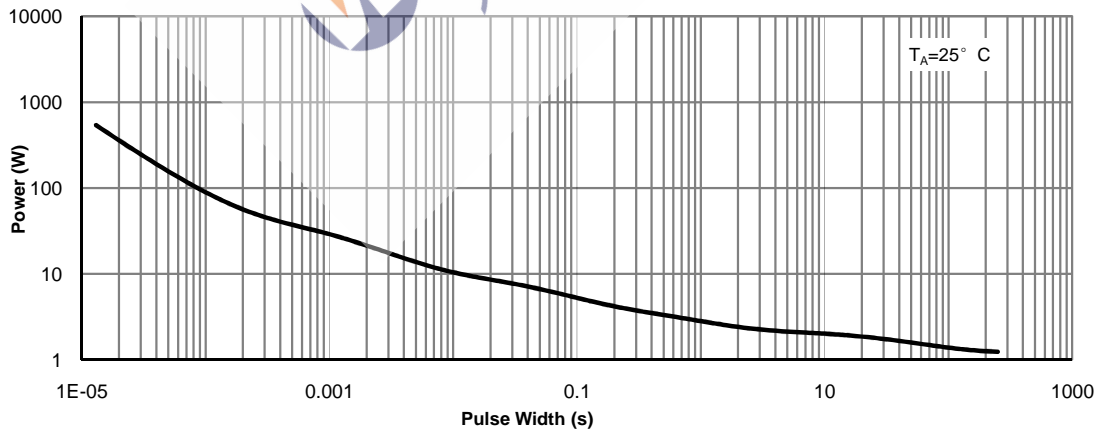
**Figure 8: Capacitance Characteristics**



**Figure 9: Single Pulse Avalanche capability (Note C)**



**Figure 10: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

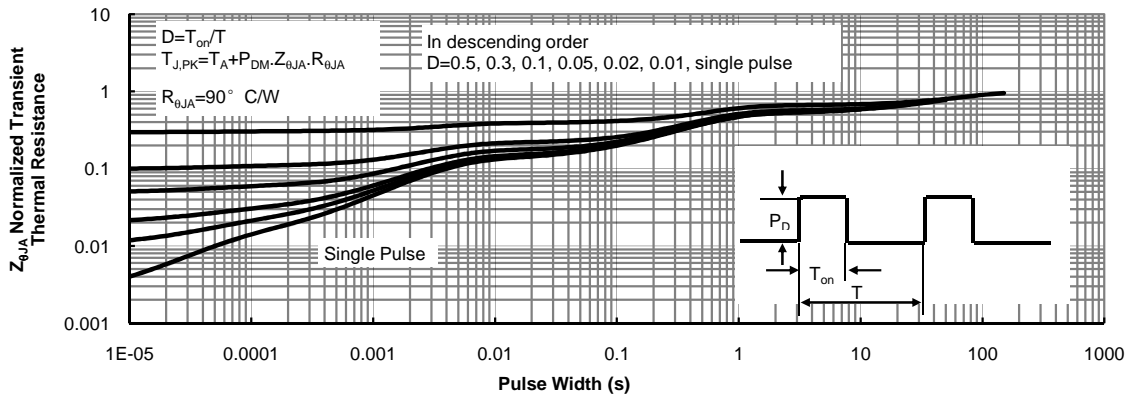
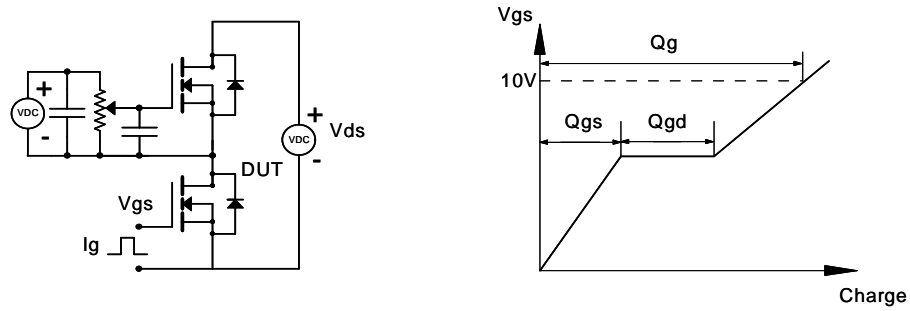


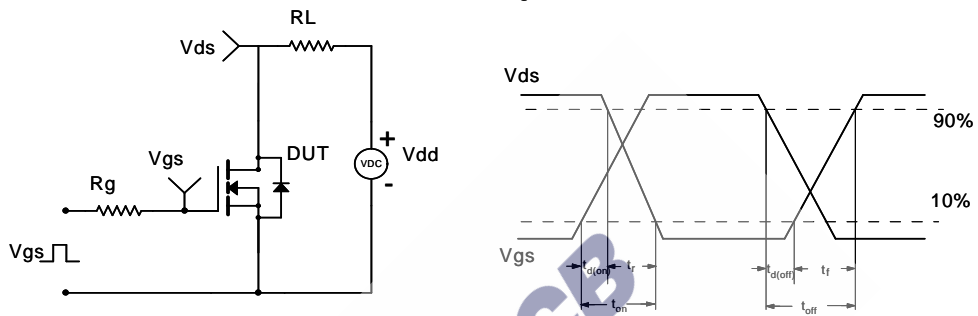
Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)



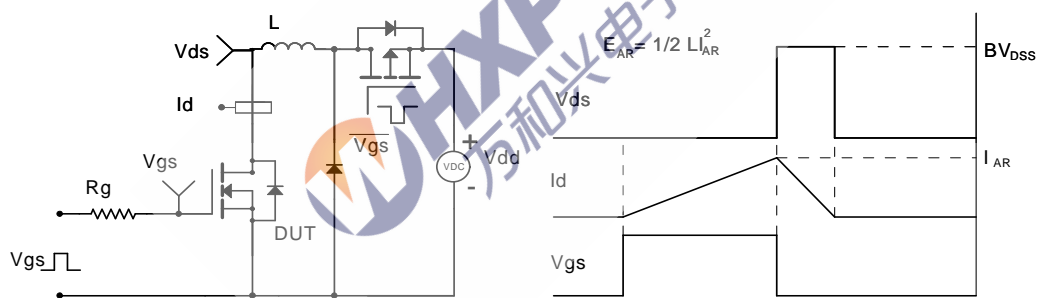
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

